

# Search Notes



Application/Control No.

10/615,870

Examiner

Hiep T. Nguyen

Applicant(s)/Patent under Reexamination

MACHIMURA ET AL.

Art Unit

2187

## SEARCHED

Class	Subclass	Date	Examiner
711	128	7/23/05	H2
"	144	"	"

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST search his. is attached	7/23/05	H2
NPL search using terms similar to EAST search.	"	"
Inventorship search.	"	"